

P-Channel 40 V (D-S), 175 °C MOSFET

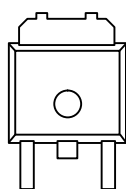
PRODUCT SUMMARY

V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^d
- 40	0.0094 at $V_{GS} = - 10$ V	- 50
	0.0145 at $V_{GS} = - 4.5$ V	- 50

FEATURES

- TrenchFET® Power MOSFETs
- 175 °C Junction Temperature
- Compliant to RoHS Directive 2002/95/EC

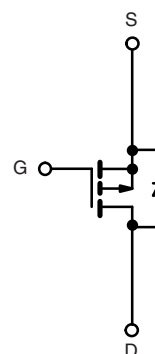

RoHS
COMPLIANT

TO-252


G D S

Top View

Drain Connected to Tab

Ordering Information: SUD50P04-09L-E3 (Lead (Pb)-free)


P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 40	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 175$ °C)	I_D	$T_C = 25$ °C - 50 ^d	A
		$T_C = 125$ °C - 50 ^d	
Pulsed Drain Current	I_{DM}	- 100	
Avalanche Current	I_{AS}	- 50	
Single Avalanche Energy ^a	E_{AS}	125	mJ
Power Dissipation	P_D	$T_C = 25$ °C 136 ^c	W
		$T_A = 25$ °C 3 ^{b, c}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient ^b	R_{thJA}	$t \leq 10$ s 15	18	°C/W
		Steady State 40	50	
Junction-to-Case	R_{thJC}	0.82	1.1	

Notes:

a. Duty cycle ≤ 1 %.

b. When mounted on 1" square PCB (FR-4 material).

c. See SOA curve for voltage derating.

d. Package limited.

SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 40			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 1		- 3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 32 V, V _{GS} = 0 V			- 1	μA
		V _{DS} = - 32 V, V _{GS} = 0 V, T _J = 125 °C			- 50	
		V _{DS} = - 32 V, V _{GS} = 0 V, T _J = 175 °C			- 150	
On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 50			A
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V, I _D = - 24 A		0.0075	0.0094	Ω
		V _{GS} = - 10 V, I _D = - 50 A, T _J = 125 °C			0.014	
		V _{GS} = - 10 V, I _D = - 50 A, T _J = 175 °C			0.017	
		V _{GS} = - 4.5 V, I _D = - 18 A		0.0115	0.0145	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 5 V, I _D = - 24 A		73		S
Dynamic ^b						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = - 25 V, f = 1 MHz		4800		pF
Output Capacitance	C _{oss}			700		
Reverse Transfer Capacitance	C _{rss}			550		
Total Gate Charge ^c	Q _g	V _{DS} = - 20 V, V _{GS} = - 10 V, I _D = - 50 A		102	150	nC
Gate-Source Charge ^c	Q _{gs}			18.5		
Gate-Drain Charge ^c	Q _{gd}			27		
Turn-On Delay Time ^c	t _{d(on)}	V _{DD} = - 20 V, R _L = 0.4 Ω I _D ≅ - 50 A, V _{GEN} = - 10 V, R _g = 6 Ω		10	15	ns
Rise Time ^c	t _r			60	90	
Turn-Off Delay Time ^c	t _{d(off)}			145	220	
Fall Time ^c	t _f			140	220	
Source Drain-Diode Ratings and Characteristics T _C = 25 °C ^b						
Continuous Current	I _S				- 50	A
Pulsed Current	I _{SM}				- 100	
Forward Voltage ^a	V _{SD}	I _F = - 50 A, V _{GS} = 0 V		- 1.0	- 1.5	V
Reverse Recovery Time	t _{rr}	I _F = - 50 A, dI/dt = 100 A/μs		55	85	ns

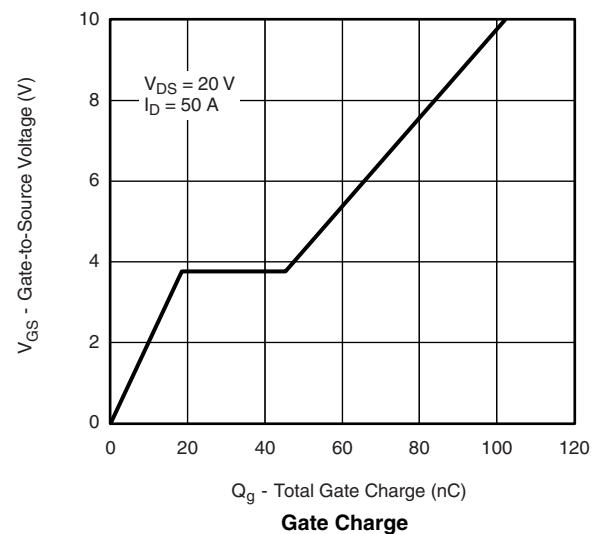
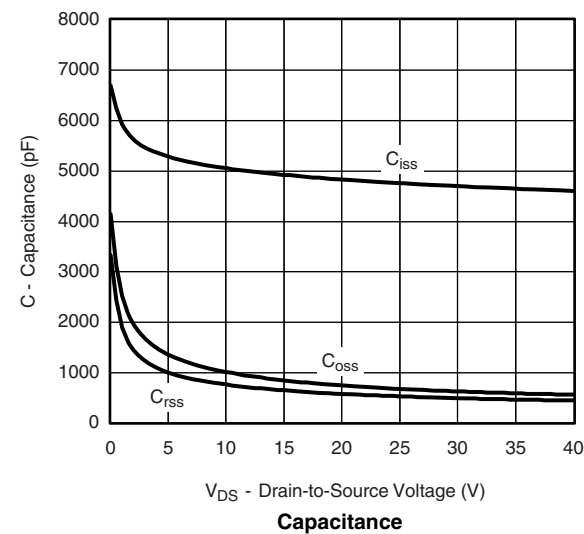
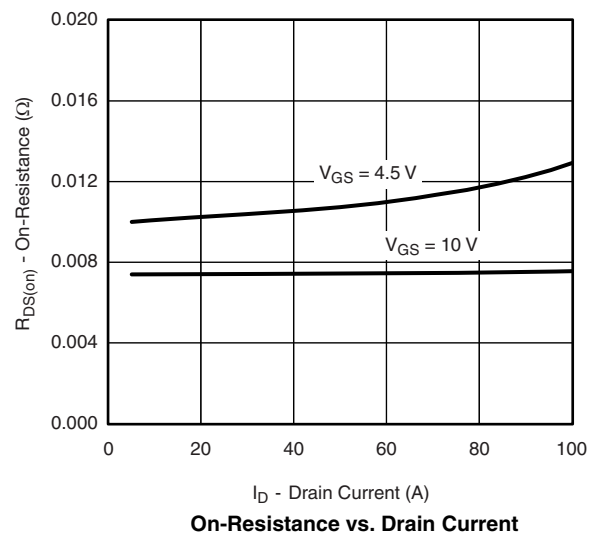
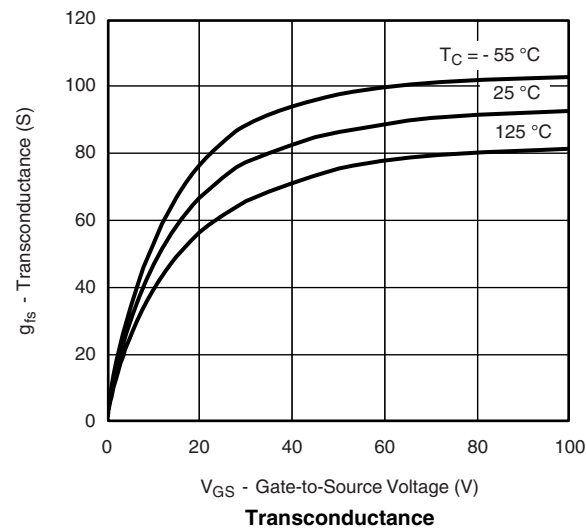
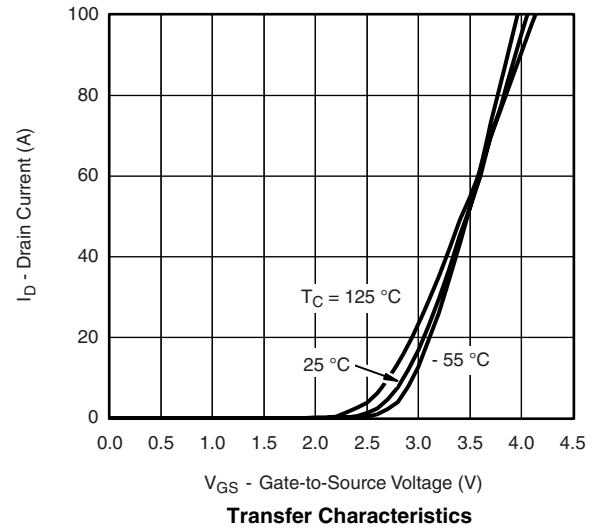
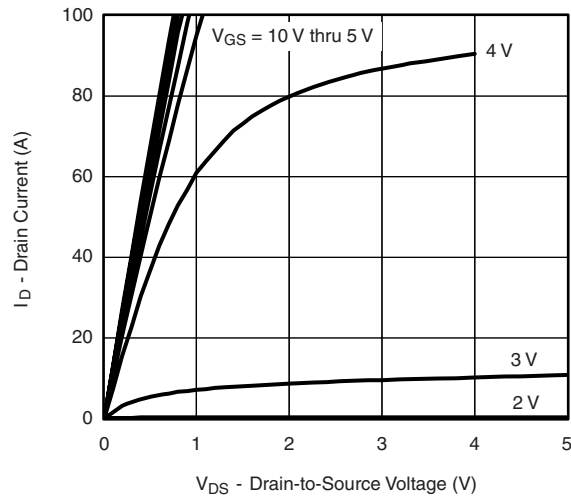
Notes:

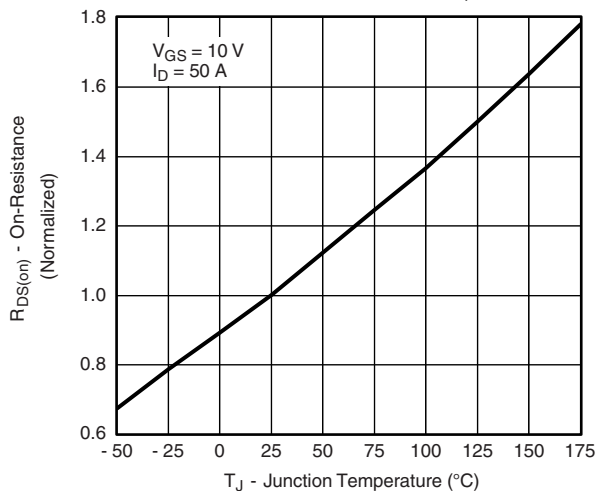
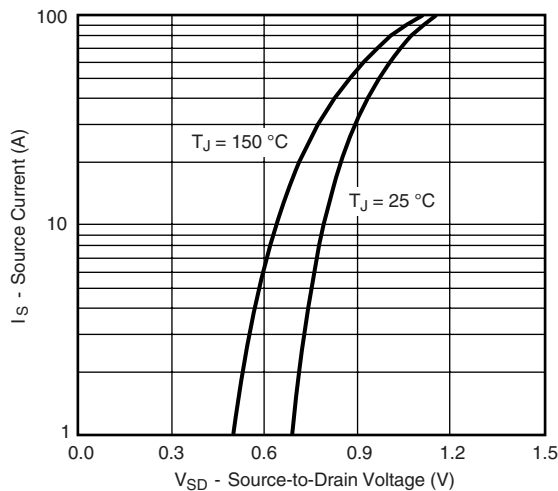
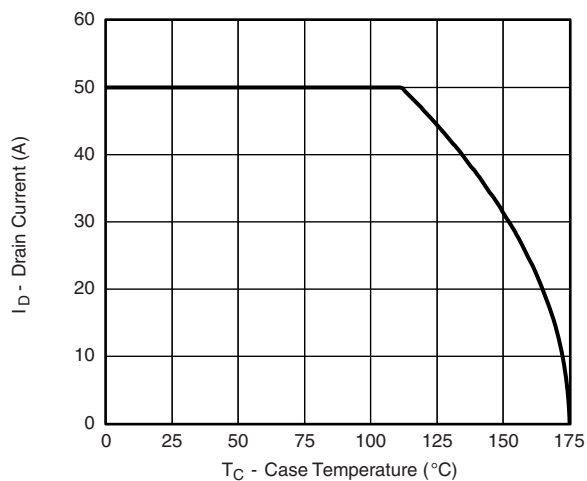
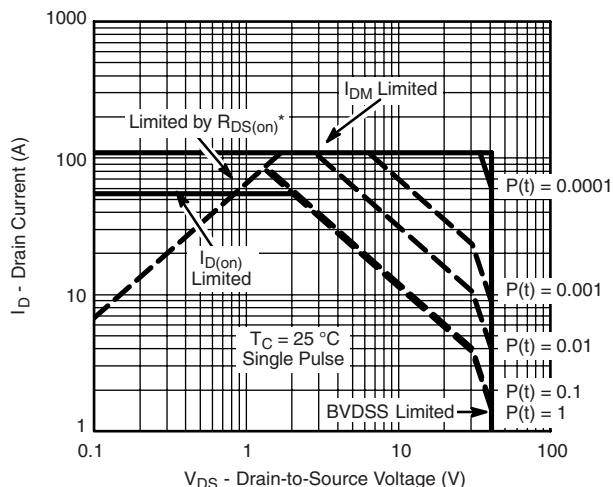
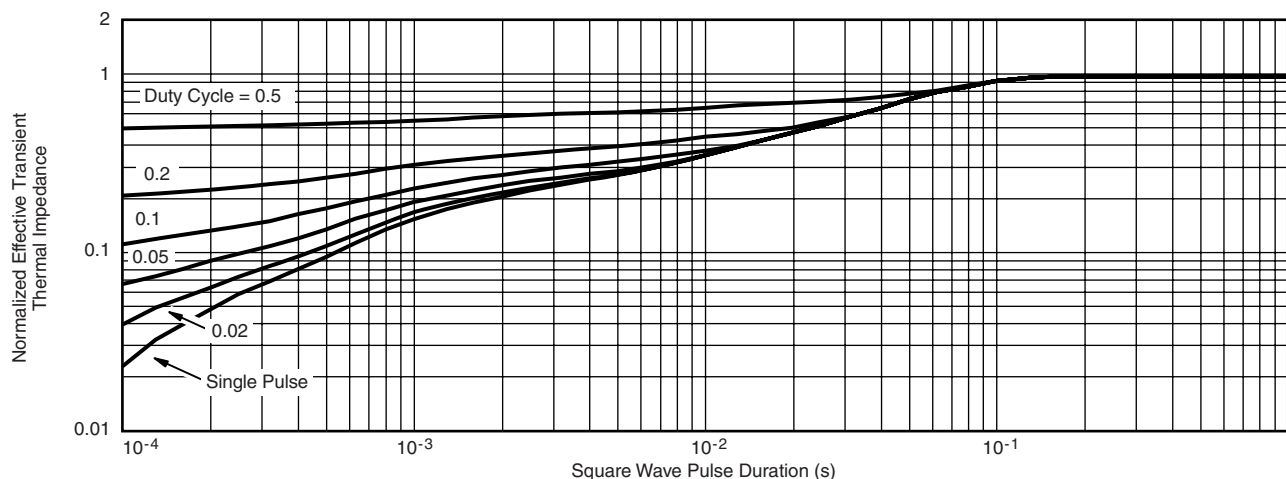
a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**On-Resistance vs. Junction Temperature****Source-Drain Diode Forward Voltage****THERMAL RATINGS****Maximum Avalanche and Drain Current vs. Case Temperature*** $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified**Safe Operating Area****Normalized Thermal Transient Impedance, Junction-to-Case**

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Тел: +7 (812) 336 43 04 (многоканальный)

Email: org@lifeelectronics.ru

www.lifeelectronics.ru